

Notice of References Cited	Application/Control No. 09/873,815		Applicant(s)/Patent Under Reexamination LAVORGNA ET AL.	
	Examiner Tan Dean D. Nguyen		Art Unit 3689	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,381,579	04-2002	Gervais et al.	705/8
*	B	US-2002/0122422	09-2002	Kenney et al.	370/392
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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